

Supplementary Information

Structure, electrical conductivity and oxygen transport properties of perovskite-type oxides $\text{CaMn}_{1-x-y}\text{Ti}_x\text{Fe}_y\text{O}_{3-\delta}$

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Table S1 Representative structural parameters for the phases of CMF. The numbers in parentheses denote standard deviations in units of the least significant digits.

Atom	Site	x	y	z	U_{iso}
30 °C (<i>Pnma</i>): $a = 5.2969(1)$ Å, $b = 7.4763(2)$ Å, $c = 5.2827(1)$ Å					
Ca	4c	0.0310(9)	0.25	-0.011(2)	0.002(1)
Mn,Fe	4b	0	0	0.5	0.00(3)
O1	4c	0.493(2)	0.25	0.053(3)	0.00(1)
O2	8d	0.268(4)	0.031(3)	0.692(3)	0.038(7)
800 °C (<i>I4/mcm</i>): $a = b = 5.3475(3)$ Å, $c = 7.5609(7)$ Å					
Ca	4b	0	0.5	0.25	0.005(1)
Mn,Fe	4c	0	0	0	0.0(2)
O1	4a	0	0	0.25	0.00(7)
O2	8h	0.221(2)	0.721(2)	0	0.099(5)
900 °C (<i>Pm</i>$\bar{3}$<i>m</i>): $a = b = c = 3.7886(5)$ Å					
Ca	1a	0	0	0	0.005(1)
Mn,Fe	1b	0.5	0.5	0.5	0.0(9)
O	3d	0.5	0.5	0	0.058(2)

Note: The reliability factors for the three structural refinements are: 30 °C (*Pnma*): $R_{\text{wp}} = 4.861\%$ and $\chi^2 = 2.84$; 800 °C (*I4/mcm*): $R_{\text{wp}} = 4.529\%$ and $\chi^2 = 2.07$; 900 °C (*Pm* $\bar{3}$ *m*): $R_{\text{wp}} = 4.855\%$ and $\chi^2 = 2.93$.

Table S2 Representative structural parameters for the phases of CMTF. The numbers in parentheses denote standard deviations in units of the least significant digits.

Atom	Site	x	y	z	U_{iso}
30 °C (<i>Pnma</i>): $a = 5.3187(1)$ Å, $b = 7.5062(3)$ Å, $c = 5.3049(1)$ Å					
Ca	4c	0.0274(8)	0.25	-0.004(3)	0.009(1)
Mn,Fe	4b	0	0	0.5	0.00(5)
O1	4c	0.490(2)	0.25	0.066(5)	0.015(8)
O2	8d	0.285(2)	0.034(2)	0.710(3)	0.021(5)
800 °C (<i>I4/mcm</i>): $a = b = 5.3653(2)$ Å, $c = 7.58325(4)$ Å					
Ca	4b	0	0.5	0.25	0.010(1)
Mn,Fe	4c	0	0	0	0.000(5)
O1	4a	0	0	0.25	0.00(1)
O2	8h	0.221(2)	0.721(2)	0	0.081(9)
900 °C (<i>Pm</i>$\bar{3}$<i>m</i>): $a = b = c = 3.7988(4)$ Å					
Ca	1a	0	0	0	0.003(1)
Mn,Fe	1b	0.5	0.5	0.5	0.00(2)
O	3d	0.5	0.5	0	0.058(2)

Note: The reliability factors for the three structural refinements are: 30 °C (*Pnma*): $R_{\text{wp}} = 3.950$ % and $\chi^2 = 2.23$; 800 °C (*I4/mcm*): $R_{\text{wp}} = 3.905$ % and $\chi^2 = 1.71$; 900 °C (*Pm* $\bar{3}$ *m*): $R_{\text{wp}} = 4.416$ % and $\chi^2 = 2.03$.

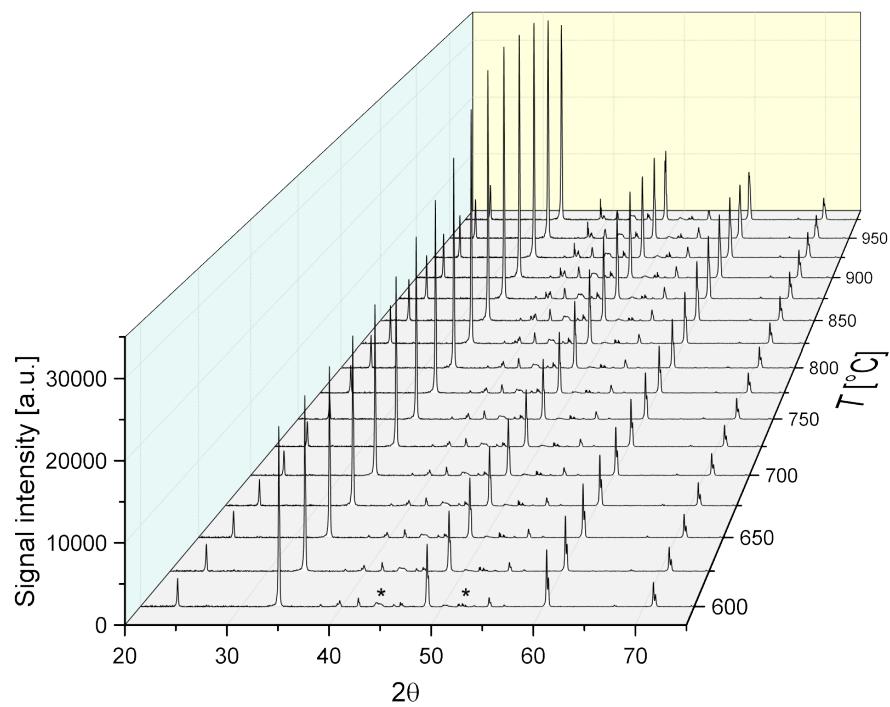


Fig. S1 HT-XRD patterns of CM recorded in air on cooling from 975 °C to 600 °C. Stars denote regions in which aberrations of the instrument are known to be present.

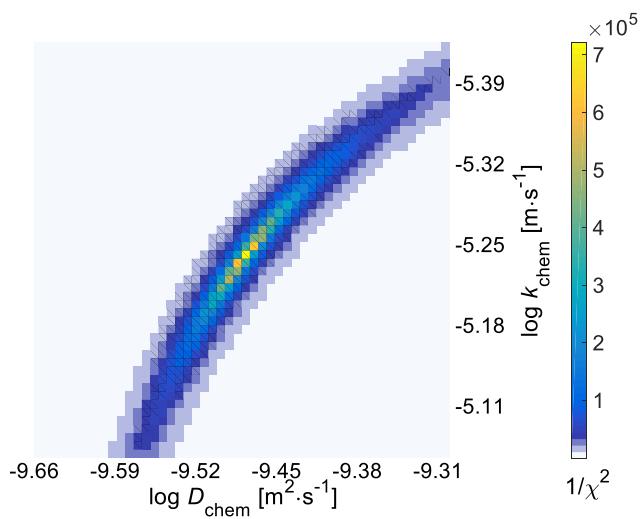
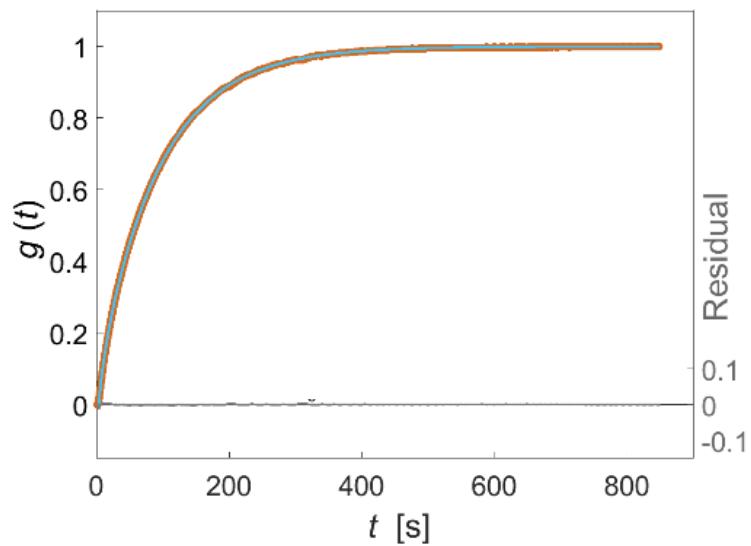


Fig. S2 (a) Normalized conductivity curve for CMF, obtained at 775 °C after a $p\text{O}_2$ step change from 0.146 to 0.215 atm. The solid blue line represents the non-linear least squares fit to Eqs. 2-4, and the residual is shown by the grey dots. (b) Corresponding error plot, in which the most probable values for D_{chem} and k_{chem} correspond with the highest value of $1/\chi^2$.